

# 9N50-CBQ

Preliminary

# 9.0A, 500V N-CHANNEL POWER MOSFET

# DESCRIPTION

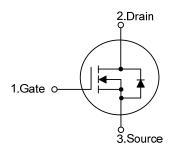
The UTC **9N50-CBQ** is an N-channel mode power MOSFET using UTC's advanced technology to provide customers planar stripe and DMOS technology. This technology allows a minimum on-state resistance, superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC **9N50-CBQ** is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.

# FEATURES

- \*  $R_{DS(ON)}$  < 1.08 $\Omega$  @  $V_{GS}$  = 10 V,  $I_D$  = 4.5 A
- \* High Switching Speed
- \* Improved dv/dt Capability
- \* 100% Avalanche Tested

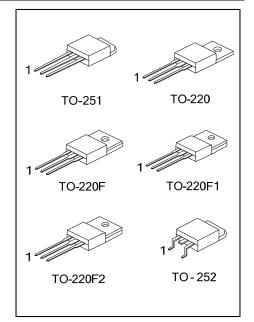
### SYMBOL



# ORDERING INFORMATION

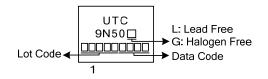
Ordering Number			Dookago	Pin Assignment			Deaking	
	Lead Free	Halogen Free	Package	1	2	3	Packing	
	9N50L-TA3-T	9N50G-TA3-T	TO-220	G	D	S	Tube	
	9N50L-TF1-T	9N50G-TF1-T	TO-220F1	G	D	S	Tube	
	9N50L-TF2-T	9N50G-TF2-T	TO-220F2	G	D	S	Tube	
	9N50L-TF3-T	9N50G-TF3-T	TO-220F	G	D	S	Tube	
	9N50L-TM3-T	9N50G-TM3-T	TO-251	G	D	S	Tape Reel	
	9N50L-TN3-R	9N50G-TN3-R	TO-252	G	D	S	Tape Reel	
Note:	Pin Assignment: G: G	ate D: Drain S: Source			3			

9N50L-TA3-T	ma ili an				
(1)Packing Type	(1) T: Tube, R: Tape Reel				
(2)Package Type	(2) TA3: TO-220, TF3: TO-220F, TF1: TO-220F1, TF2: TO-220F2, TM3: TO-251, TN3: TO-252				
(3)Green Package	(3) L: Lead Free, G: Halogen Free and Lead Free				
STO N. N.					
C WW					



# 9N50-CBQ

# MARKING



UNISONIC TECHINOLOGIES CO., LTD www.unisonic.com.tw

#### ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>C</sub>=25°C, unless otherwise noted)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V <sub>DSS</sub>	500	V
Gate-Source Voltage		V <sub>GSS</sub>	±30	V
Drain Current	Continuous (T <sub>C</sub> =25°C)	ID	9	А
Drain Current	Pulsed (Note 2)	I <sub>DM</sub>	36	А
Avalanche Current (Note	3)	I <sub>AR</sub>	3.4	А
Avalanche Energy	Single Pulsed (Note 3)	Single Pulsed (Note 3) E <sub>AS</sub> 58		mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns
	TO-220		140	W
Power Dissipation	TO-220F/TO-220F1 TO-220F2	P <sub>D</sub>	47	w
TO-220F2 TO-251/TO-252 100	100	W		
Junction Temperature		TJ	+150	°C
Storage Temperature		T <sub>STG</sub>	-55~+150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

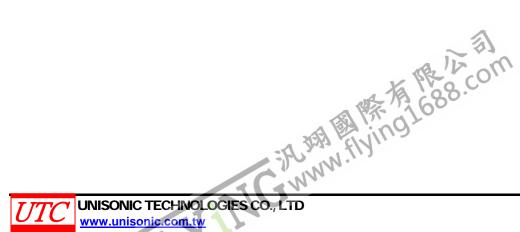
2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 10mH,  $I_{AS}$  = 3.4A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25°C

4.  $I_{SD} \le 9A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ 

### THERMAL DATA

PAR	AMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	TO-220/TO-220F TO-220F1/TO-220F2	θ <sub>JA</sub>	62.5	°C/W	
	TO-251/TO-252		110	1	
	TO-220		0.9		
Junction to Case	TO-220F/TO-220F1 TO-220F2	θ <sub>JC</sub>	2.65	°C/W	
	TO-251/TO-252		1.25		



### ■ ELECTRICAL CHARACTERISTICS (T<sub>c</sub>=25°C, unless otherwise noted)

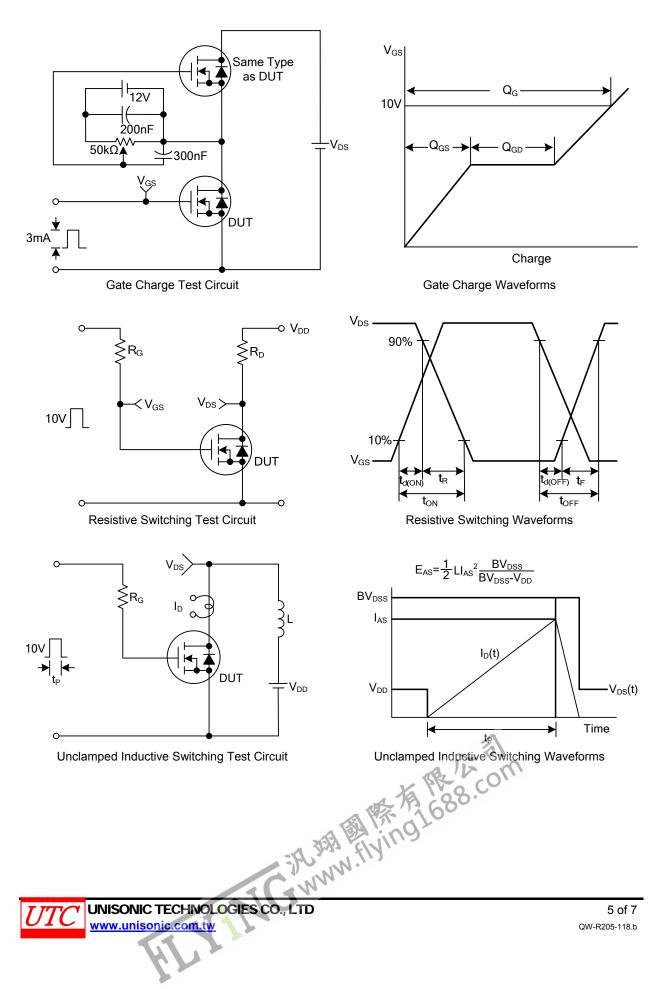
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PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS				_			
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	500			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =500V, V <sub>GS</sub> =0V			1	μA
Gate- Source Leakage Current	Forward	- I <sub>GSS</sub>	V <sub>GS</sub> =+30V, V <sub>DS</sub> =0V			+100	nA
	Reverse		V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	2.0		4.0	V
Static Drain-Source On-State Res	sistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =4.5A			1.08	Ω
DYNAMIC PARAMETERS			_	_			
Input Capacitance		C <sub>ISS</sub>			860		рF
Output Capacitance Reverse Transfer Capacitance		Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		90		pF
					13		рF
SWITCHING PARAMETERS			_	_			
Total Gate Charge		$Q_{G}$			46		nC
Gate to Source Charge		$Q_{GS}$	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>D</sub> =1.3A I <sub>G</sub> =100µA (Note 1, 2)		4		nC
Gate to Drain Charge			$I_{G} = 100 \mu A (100 e^{-1}, 2)$		2.6		nC
Turn-ON Delay Time		t <sub>D(ON)</sub>			46		ns
Rise Time	-		V <sub>DD</sub> =30V, V <sub>GS</sub> =10V, I <sub>D</sub> =0.5A,		21		ns
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		152		ns
Fall-Time		t <sub>F</sub>			30		ns
SOURCE- DRAIN DIODE RATIN	IGS AND (	CHARACTERI	STICS				
Maximum Body-Diode Continuou	s Current	Is				9	Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>				36	Α
Drain-Source Diode Forward Volt	ain-Source Diode Forward Voltage		I <sub>S</sub> =9A, V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time		V <sub>SD</sub> t <sub>rr</sub>			348		ns
Body Diode Reverse Recovery Charge		Qrr	I <sub>SD</sub> =9A, dI <sub>S</sub> /dt=100A/μs		3.0		nC
Nataou 4, Dulae Teeta Dulae width < 200 ve. Duth evelo < 20/							

Notes: 1. Pulse Test: Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2%.

2. Essentially independent of operating temperature.

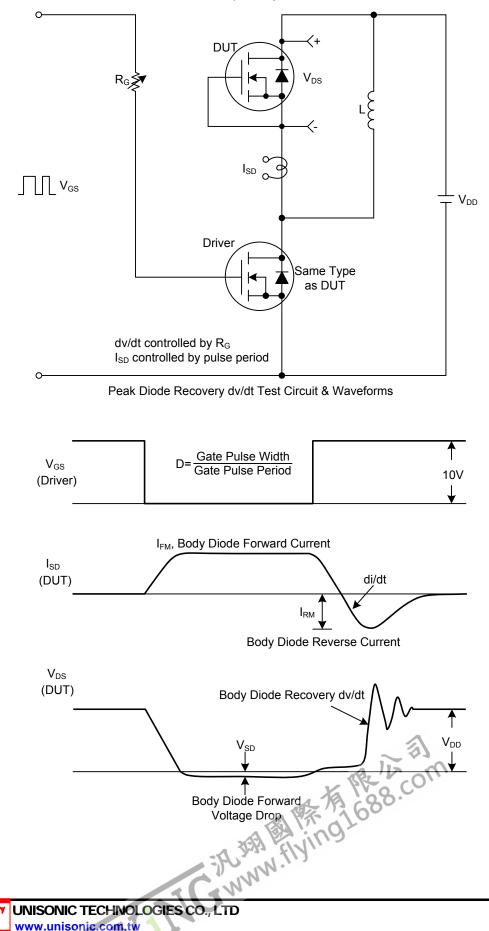


### TEST CIRCUITS AND WAVEFORMS



# 9N50-CBQ

# ■ TEST CIRCUITS AND WAVEFORMS(Cont.)



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